

Contact-mode scanning tunneling microscopy experimental technique employed for tunneling magnetoresistance measurements

Podgurski, Vitali; Adam, R.; Teske, M.; Krämer, Martina; Franchy, R. Review of scientific instruments 2006 / p. 033906-1 - 033906-3 : ill

Growth of ultra-thin amorphous Al₂O₃ films on CoAl(1 0 0)

Rose, V.; **Podgurski, Vitali**; Costina, Ioan; Franchy, R. Surface science 2003 / p. 128-136
<https://www.sciencedirect.com/science/article/pii/S0039602803008914>

Ultra thin Al₂O₃ films grown on Ni₃Al(1 0 0)

Podgurski, Vitali; Costina, Ioan; Franchy, R. Applied surface science 2003 / p. 29-36 : ill
<https://www.sciencedirect.com/science/article/pii/S0169433202008024>